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U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
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Date Submitted to PTO: March 24, 2005

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Keisuke OHNISHI et al.FILING DATE  
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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/YB/	AG	2002-082606	3/2002	JP			Abstract
/YB/	AH	2001-356021	12/2001	JP			Abstract
/YB/	AI	2000-067364	3/2000	JP			Abstract
/YB/	AJ	2001-175982	6/2001	JP			Abstract
/YB/	AK	2001-141486	5/2001	JP			Abstract
/YB/	AL	2002-257561	9/2002	JP			Abstract
/YB/	AM	2002-073758	3/2002	JP			Abstract
	AN						

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

AO	
AP	
AQ	

EXAMINER /Yonel Beaulieu/ (01/11/2008) DATE CONSIDERED

## INFORMATION DISCLOSURE STATEMENT

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
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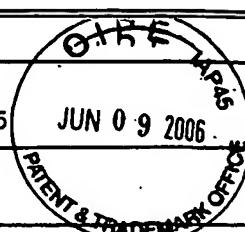
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## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/YB/	AJ	2002-82606	3/2002	JP			abstract
/YB/	AK	2001-356021	12/2001	JP			abstract
/YB/	AL	2000-67364	3/2000	JP			abstract
/YB/	AM	2001-175982	6/2001	JP			abstract
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## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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